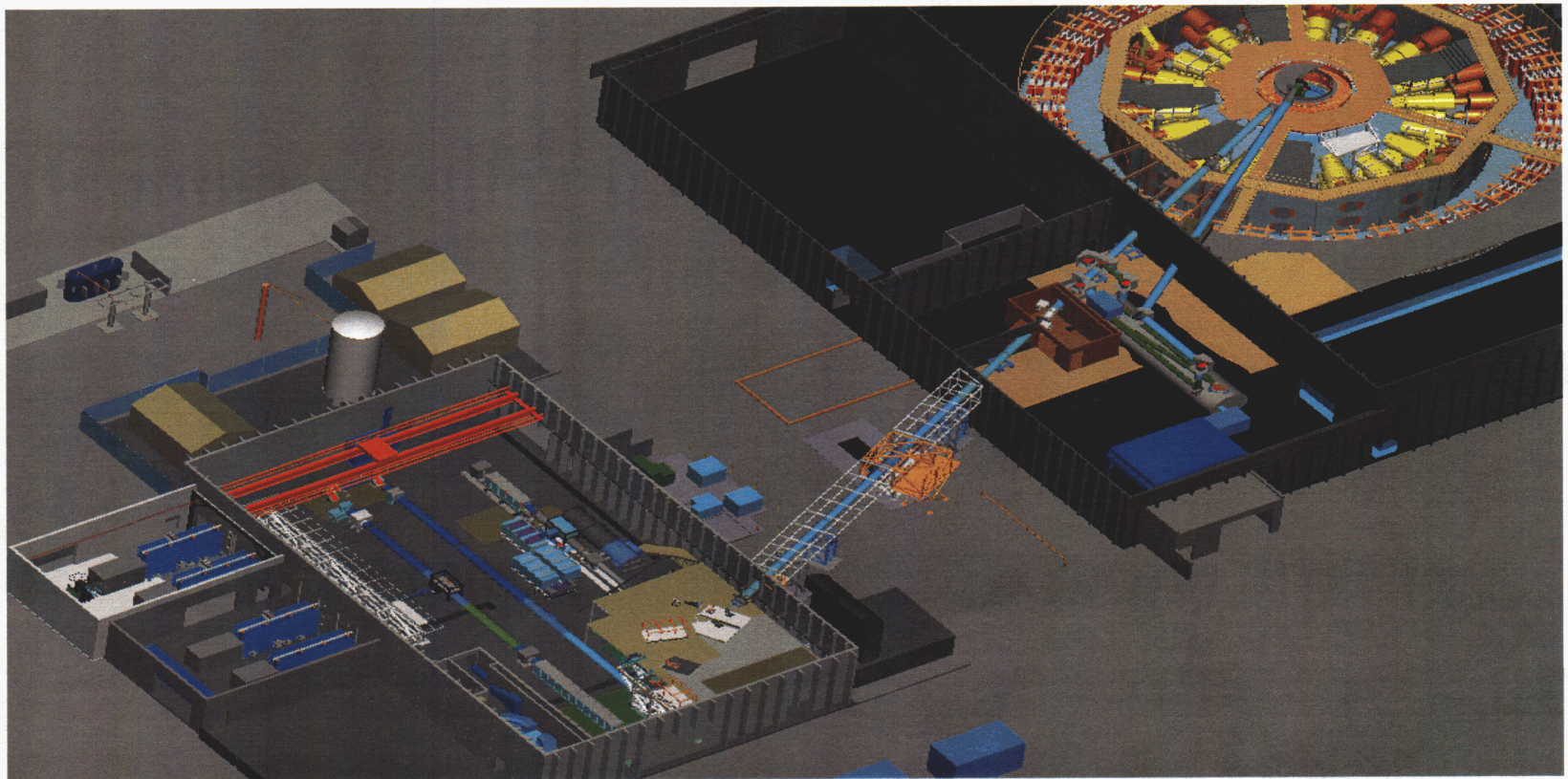




Z Beamlet enables backlighting experiments on Z

Z facility



Z Beamlet laser facility

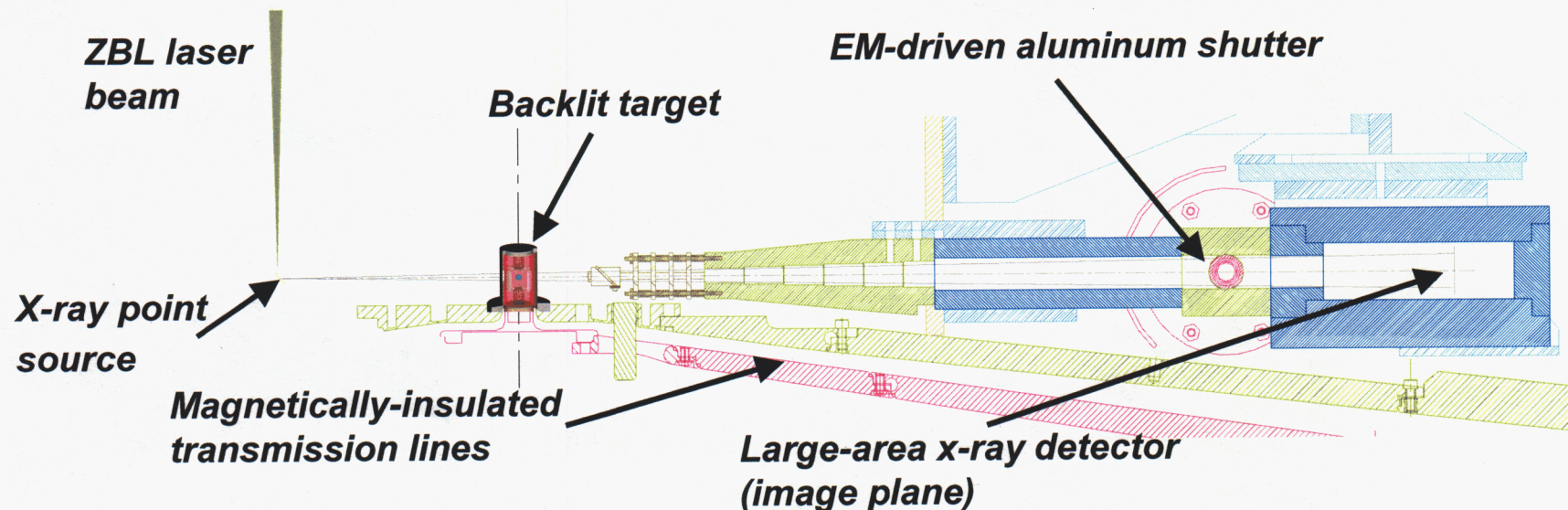
Sandia is a multiprogram laboratory
operated by Sandia Corporation, a
Lockheed Martin Company, for the
United States Department of Energy
under contract DE-AC04-94AL85000.



Z-Beamlet is now being used to x-ray image ICF capsules in z-pinch-driven hohlraums

During the fall of '98 Beamlet was dismantled at LLNL and shipped to Sandia.

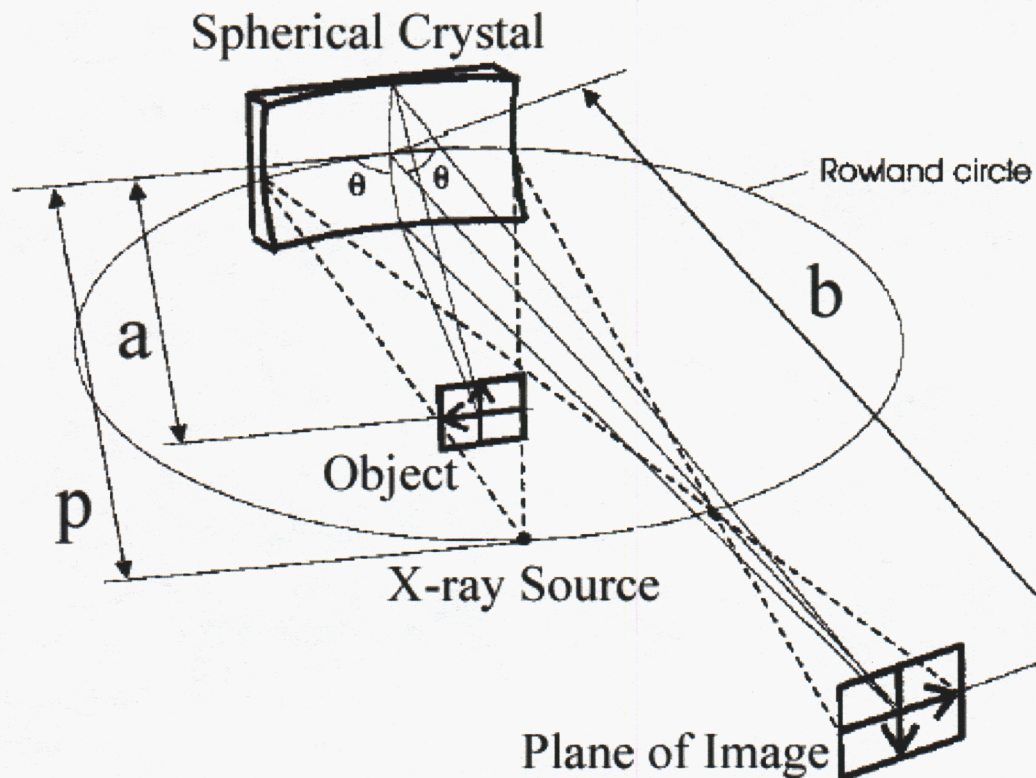
The first experiments, Z shots 765-767, were performed during June 2001. The second backlighter series, Z826-839, occurred in Nov-Dec 2001. A third series is underway now.



Shielding / collimation reduces bremsstrahlung background to tolerable levels

EM-driven shutter successfully protects detector film/filter pack from debris

Bragg reflection off spherically bent crystals provides essentially monochromatic backlighting



• Advantages

- Narrow spectral bandpass $\Delta E < .001 \text{ keV}$
- avoids background radiation
- < 10 micron resolution
- Large field of view (e.g. 20 mm by 5 mm)

• Disadvantages

- More complex alignment
- Crystal must be inside blast shield, likely to be destroyed each shot

S.A. Pikuz, *et al.*, JETP Lett. **61**, 638 (1995);

S.A. Pikuz, *et al.*, Rev. Sci. Instrum. **68**, 740 (1997).

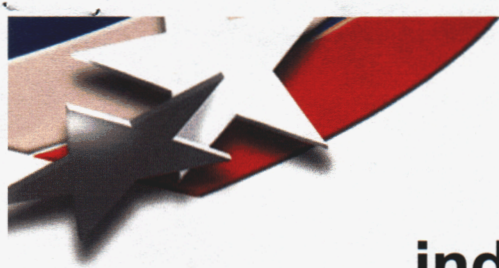
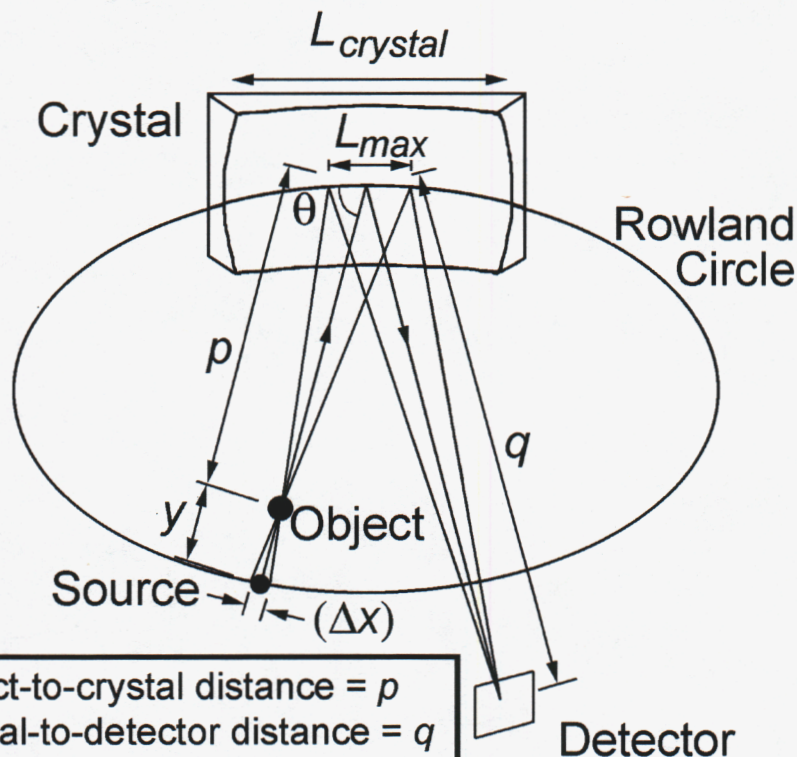


Image resolution is nearly independent of the x-ray source size



Object-to-crystal distance = p
 Crystal-to-detector distance = q
 Crystal bending radius = R
 Rowland Circle radius = $R/2$

Detector position at focal position of the object:

$$1/p + 1/q = 2 / (R \sin\theta)$$

Field of view:

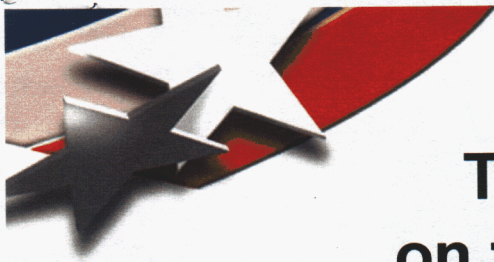
$$FOV = L_{crystal} \{y/(p+y)\}$$

Spectral bandpass:

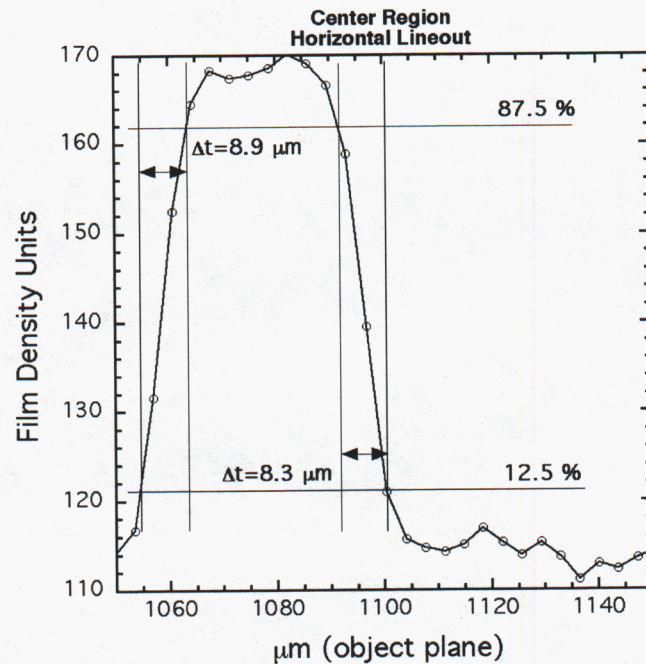
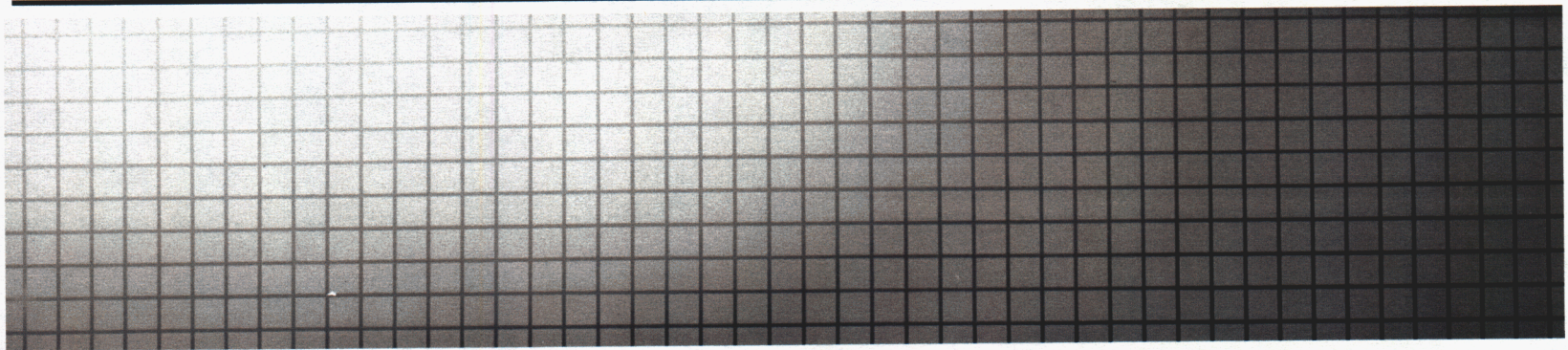
$$\Delta\lambda/\lambda = (\Delta x/R) \cot(\theta)$$

Magnification:

$$M = q / p$$



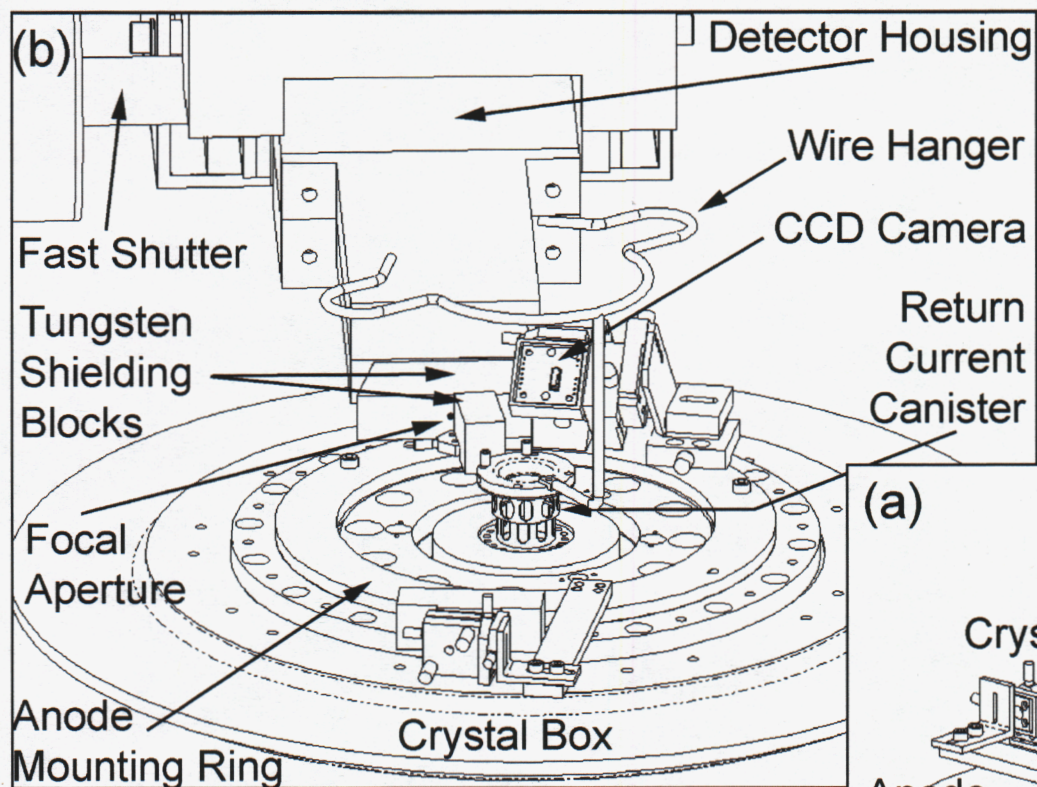
The 1.865 keV system was tested on the Z-Beamlet calibration chamber



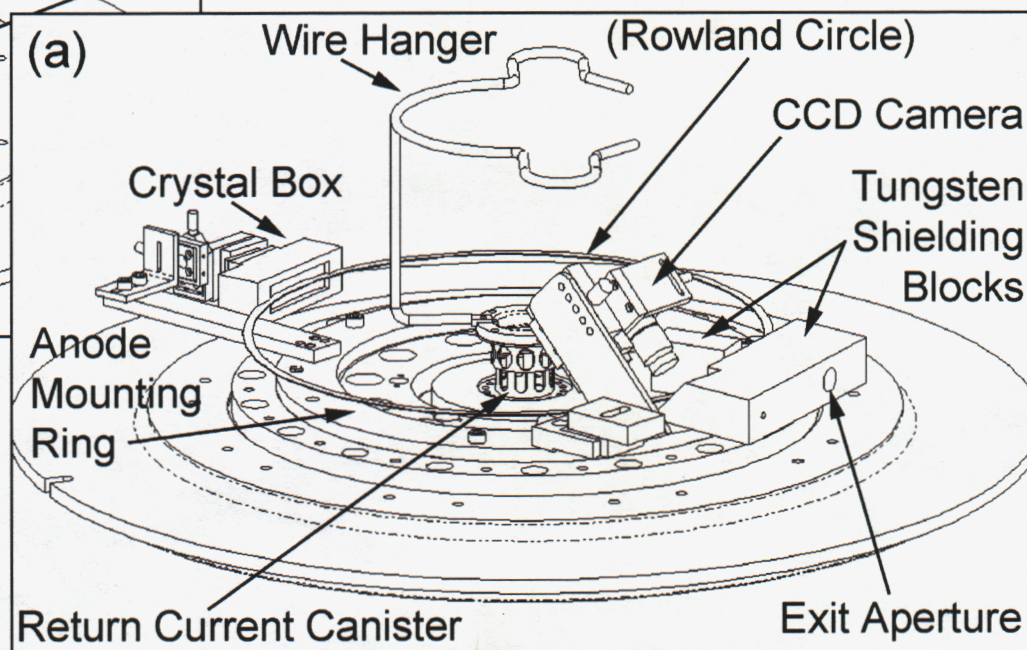
- The Si He- α imaging system has been tested in the ZBL calibration chamber in a Z-identical geometry.
- Images of $33.5 \mu\text{m}$ diameter electroformed meshes have been obtained with $\sim 10 \mu\text{m}$ resolution.

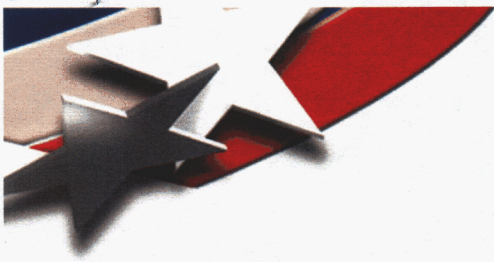


Schematic of Monochromatic X-ray Backlighting System on Z



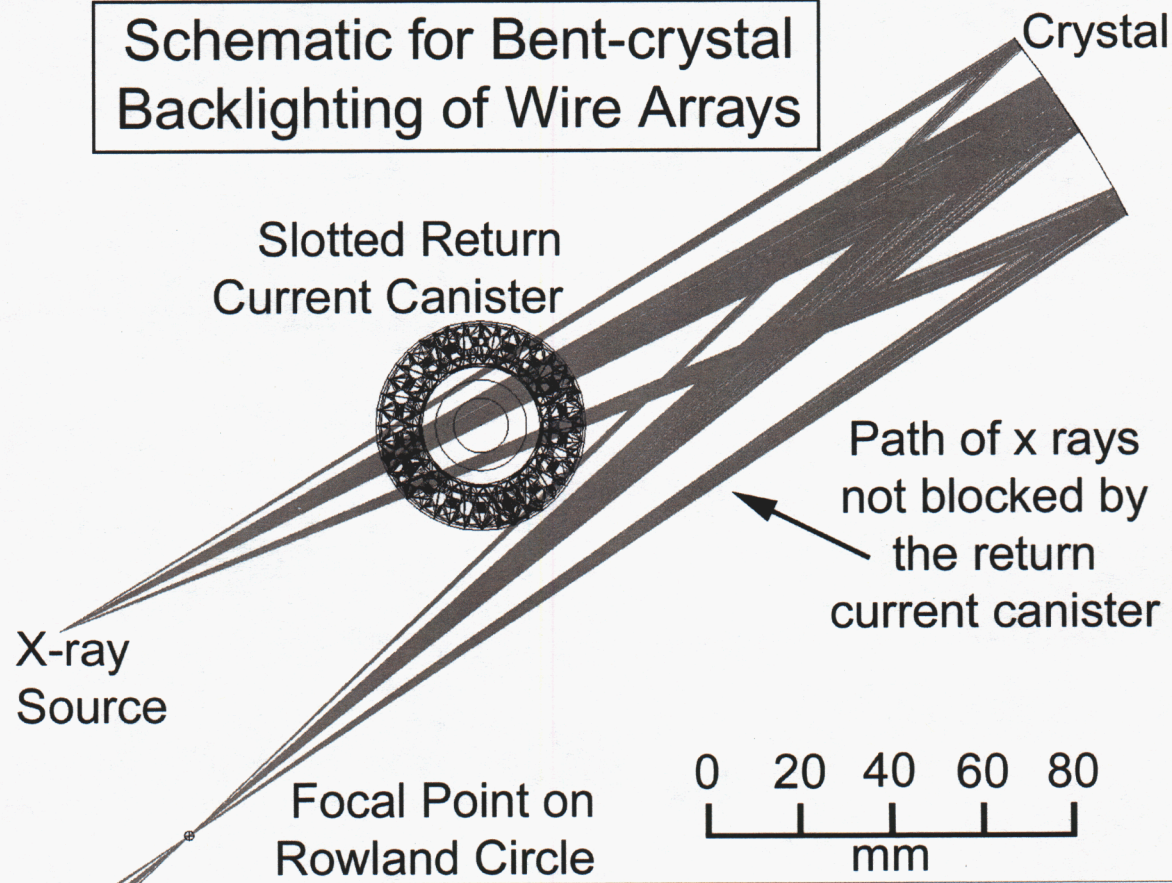
This hardware will be fielded next on 3 shots in September and 7 shots during October 2002.





Field of View for June Z Shots

Schematic for Bent-crystal Backlighting of Wire Arrays



- 20 and/or 12 mm diameter wire arrays will be fielded.

- The unblocked field of view of the crystal is 20 mm.

- View of pinch at stagnation will be blocked using Au foil.



X-ray backlighting of the wire array was attempted on two shots

Two-dimensional (“r-z”), monochromatic x-ray backlighting was used during Z931 and Z932 to look at the motion of the wire array.

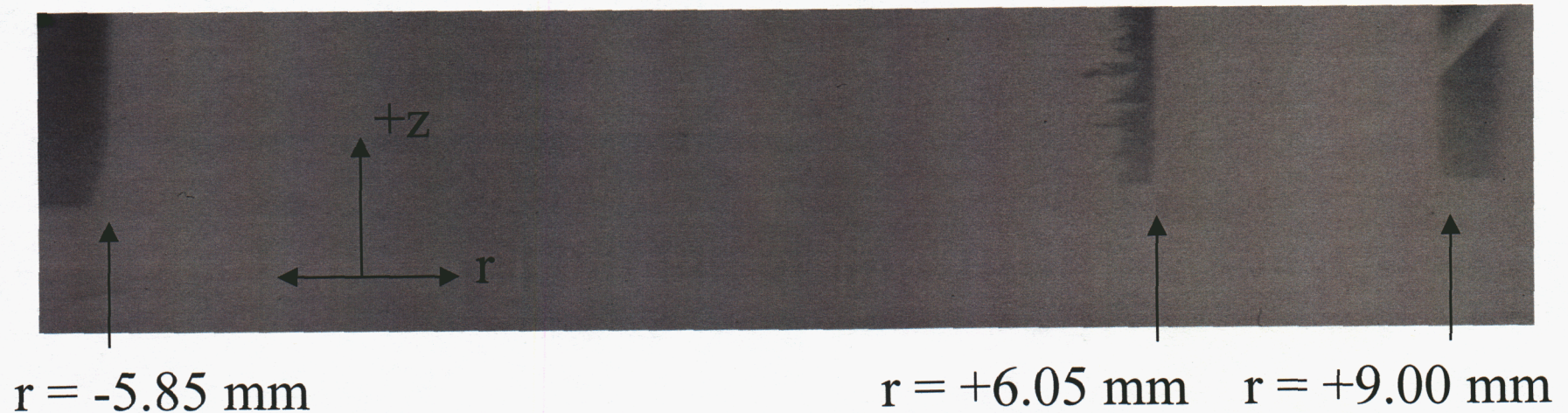
The x-ray source was a Si target illuminated by the Z-Beamlet laser. The Si He_{α} line at 1.865 keV was used as the backlighter source.

These shots were the first tests of a bent-crystal radiography system on the Z-machine.

Partial success: an image was obtained on Z931 but not on Z932—crystal heating likely to blame.



Bent-Crystal Radiography (BCR) Results



Radiography film from Z931: A single, 12 mm diameter, 15 mg/cm, 180 W wire array. RAK gap was very large—9 mm! (7.5 mm slot width)

Only one of the three fields of view through the return-current can was expected to contain data.



Boundary of wire-array mass visible through center slot

Radial location of outer slot edge determined using ray-tracing to be 6.05 mm +/- 0.15 mm.

Complex axial structure is clearly visible. FFT analysis shows that the dominant wavelength is 304 μm , but there were also peaks at 234, 176, 141, and perhaps 66 μm . Are these harmonics of a 60 μm wavelength?

Contrast is poor compared to ZBL tests of backlighter. Believe crystal heating is responsible.

1/e attenuation of 1.865 keV x rays in W at 10^{18} atoms/cm², or 0.305 mg/cm². Wire array was 15 mg.

